

**Amendments to the claims:**

This listing of claims will replace all prior versions and listing of claims in the application.

1. (Cancelled)

2. (Cancelled)

3. (Cancelled)

4. (Currently Amended) A method of measuring a DUT comprising the steps of:  
providing a vector network analyzer having at least two measurement ports,  
measuring a reflection characteristic of a high reflect calibration standard at each measurement port,  
measuring forward and reverse reflection and transmission characteristics of a line calibration standard,  
measuring forward and reverse reflection and transmission characteristics of a source terminated thru calibration standard,  
measuring forward and reverse reflection and transmission characteristics of a locally terminated thru calibration standard,

calculating error coefficients for said at  
least two measurement ports based upon  
results in said steps of measuring,  
calculating a shifted electrical length  
attributable to said calibration standards  
based upon results in said steps of  
measuring,  
connecting the DUT to the measurement ports,  
measuring s-parameters at the measurement  
ports,  
correcting for systematic errors in said s-  
parameters based upon said error  
coefficients to yield a corrected S-  
parameter matrix, and  
shifting a reference plane for each element of  
said corrected S-parameter matrix to  
coincide with a measurement reference  
plane  
wherein a shifted electrical length between  
said indirect pairs is calculated using  
load match and source match error  
coefficient terms, and  
~~A method of measuring as recited in claim 3~~

$$\frac{\Gamma_{SA\_portn}}{\Gamma_{LA\_portm}} = S_{21\_thru\_nm} S_{12\_thru\_nm}$$

wherein  $S_{21\_thru\_nm}$  is equal to  $S_{12\_thru\_nm}$  and an argument of both solutions for  $S_{21\_thru\_nm}$  is fit to a straight line, the solution having a y-

intercept closest to zero being ~~the~~a correct solution and ~~the~~a resulting argument of the correct solution being the electrical delay.

5. (Cancelled)

6. (Cancelled)

7. (Cancelled)

8. (Currently Amended) A method of measuring a DUT comprising the steps of:

providing a vector network analyzer having at least two measurement ports,

measuring a reflection characteristic of a high reflect calibration standard at each measurement port,

measuring forward and reverse reflection and transmission characteristics of a line calibration standard,

measuring forward and reverse reflection and transmission characteristics of a source terminated thru calibration standard,

measuring forward and reverse reflection and transmission characteristics of a locally terminated thru calibration standard,

calculating error coefficients for said at  
least two measurement ports based upon  
results in said steps of measuring,  
calculating a shifted electrical length  
attributable to said calibration standards  
based upon results in said steps of  
measuring,  
connecting the DUT to the measurement ports,  
measuring s-parameters at the measurement  
ports,  
correcting for systematic errors in said s-  
parameters based upon said error  
coefficients to yield a corrected S-  
parameter matrix, and  
shifting a reference plane for each element of  
said corrected S-parameter matrix to  
coincide with a measurement reference  
plane,  
measuring forward and reverse reflection and  
transmission characteristics of a source  
terminated thru calibration standard for  
indirect pairs of said measurement ports,  
wherein the step of calculating further  
comprises calculating a different  
respective shifted electrical length for  
each said direct and indirect pair, and  
wherein said shifted electrical length between  
proximal pairs is determined by averaging

a shifted electrical length between said direct pair and said indirect pair having respective proximal pair measurement ports in common.

9. (Cancelled)

10. (Cancelled)

11. (Cancelled)

12. (Cancelled)

13. (Currently Amended) A method of measuring a DUT comprising the steps of:  
providing a vector network analyzer having at least two measurement ports,  
measuring a reflection characteristic of a high reflect calibration standard at each measurement port,  
measuring forward and reverse reflection and transmission characteristics of a line calibration standard,  
measuring forward and reverse reflection and transmission characteristics of a source terminated thru calibration standard,

measuring forward and reverse reflection and  
transmission characteristics of a locally  
terminated thru calibration standard,  
calculating error coefficients for said at  
least two measurement ports based upon  
results in said steps of measuring,  
calculating a shifted electrical length  
attributable to said calibration standards  
based upon results in said steps of  
measuring,  
connecting the DUT to the measurement ports,  
measuring s-parameters at the measurement  
ports,  
correcting for systematic errors in said s-  
parameters based upon said error  
coefficients to yield a corrected S-  
parameter matrix, and  
shifting a reference plane for each element of  
said corrected S-parameter matrix to  
coincide with a measurement reference  
plane, and  
determining a type of high reflect calibration  
standard, comprising

~~A method of measuring as recited in claim 12~~  
~~wherein said step of determining further~~  
~~comprises~~ calculating a characteristic of said  
high reflect calibration standard, fitting  
arguments of two possible solutions for said

characteristics to a straight line, identifying  
~~which~~ a solution is closest to zero phase at  
DC.

14. (Cancelled)

15. (Cancelled)

16. (Currently Amended) A method of measuring  
a DUT comprising the steps of:  
providing a vector network analyzer having more  
than two measurement ports,  
measuring a reflection characteristic of a high  
reflect calibration standard at each  
measurement port,  
measuring forward and reverse reflection and  
transmission characteristics of a line  
calibration standard for direct pairs of  
the measurement ports,  
measuring forward and reverse reflection and  
transmission characteristics of a source  
terminated thru calibration standard for  
indirect pairs of the measurement ports,  
measuring forward and reverse reflection and  
transmission characteristics of a locally  
terminated thru calibration standard for  
the indirect pairs,

calculating error coefficients for said at  
least two measurement ports based upon  
results in said steps of measuring,  
calculating a shifted electrical length  
attributable to said calibration standards  
based upon results in said steps of  
measuring for each direct and indirect  
pair,  
connecting the DUT to the measurement ports,  
measuring s-parameters at the measurement  
ports,  
correcting for systematic errors in said s-  
parameters based upon said error  
coefficients to yield a corrected S-  
parameter matrix, and  
shifting a reference plane for each element of  
said corrected S-parameter matrix to  
coincide with a measurement reference  
plane comprising modifying an argument of  
respective S-parameters according to  
respective ones of the shifted electrical  
lengths comprising

~~A method of measuring as recited in claim 15~~  
~~wherein said step of shifting a reference plane~~  
~~comprises~~ adjusting each said element of said  
corrected S-parameter matrix according to:

$$S_{dut} = |\rho| e^{-j(\theta_0 + \delta\theta(f))}$$

wherein  $\delta\theta$  is calculated from said electrical



length as a function of frequency.

17. (Currently Amended) A method of measuring a DUT comprising the steps of:  
providing a vector network analyzer having at least two measurement ports,  
measuring a reflection characteristic of a high reflect calibration standard at each measurement port,  
measuring forward and reverse reflection and transmission characteristics of a line calibration standard,  
measuring forward and reverse reflection and transmission characteristics of a source terminated thru calibration standard,  
measuring forward and reverse reflection and transmission characteristics of a locally terminated thru calibration standard,  
calculating error coefficients for said at least two measurement ports based upon results in said steps of measuring,  
calculating a shifted electrical length attributable to said calibration standards based upon results in said steps of measuring by ~~A method of measuring as recited in claim 1 wherein said step of calculating a shifted electrical length comprises calculating a characteristic of~~

· said high reflect calibration standard,  
fitting an argument of said characteristic  
to a straight line, and using a slope of  
said straight line to calculate a shifted  
electrical length,

connecting the DUT to the measurement ports,  
measuring s-parameters at the measurement  
ports,

correcting for systematic errors in said s-  
parameters based upon said error  
coefficients to yield a corrected S-  
parameter matrix, and

shifting a reference plane for each element of  
said corrected S-parameter matrix to  
coincide with a measurement reference  
plane.

18.       through 72. (Cancelled)